



FDP17N60N / FDPF17N60NT

N-Channel MOSFET

600V, 17A, 0.34Ω

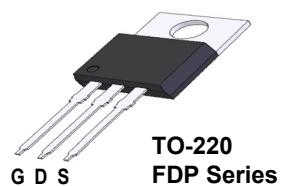
Features

- $R_{DS(on)} = 0.29\Omega$ (Typ.) @ $V_{GS} = 10V$, $I_D = 8.5A$
- Low Gate Charge (Typ. 48nC)
- Low C_{rss} (Typ. 23pF)
- Fast Switching
- 100% Avalanche Tested
- Improved dv/dt Capability
- RoHS Compliant

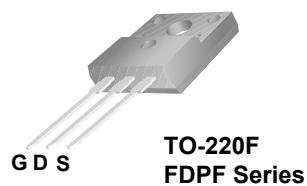
Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

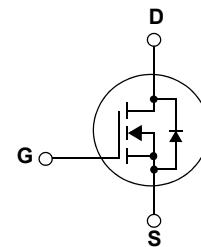
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies and active power factor correction.



TO-220
FDP Series



TO-220F
FDPF Series



MOSFET Maximum Ratings $T_C = 25^\circ C$ unless otherwise noted*

Symbol	Parameter		FDP17N60N	FDPF17N60NT	Units
V_{DSS}	Drain to Source Voltage		600		V
V_{GSS}	Gate to Source Voltage		± 30		V
I_D	Drain Current	-Continuous ($T_C = 25^\circ C$)	17	17*	A
		-Continuous ($T_C = 100^\circ C$)	10.2	10.2*	
I_{DM}	Drain Current	- Pulsed (Note 1)	68	68*	A
E_{AS}	Single Pulsed Avalanche Energy (Note 2)		838		mJ
I_{AR}	Avalanche Current (Note 1)		17		A
E_{AR}	Repetitive Avalanche Energy (Note 1)		24.5		mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		10		V/ns
P_D	Power Dissipation ($T_C = 25^\circ C$)	245	62.5		W
		- Derate above $25^\circ C$	2.0	0.5	W/ $^\circ C$
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to $+150$		$^\circ C$
T_L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300		$^\circ C$

*Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	FDP17N60N	FDPF17N60NT	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.51	2.0	$^\circ C/W$
$R_{\theta CS}$	Thermal Resistance, Case to Heat Sink Typ.	-	-	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	62.5	62.5	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP17N60N	FDP17N60N	TO-220	-	-	50
FDPF17N60NT	FDPF17N60NT	TO-220F	-	-	50

Electrical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
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Off Characteristics

BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}, T_C = 25^\circ\text{C}$	600	-	-	V
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu\text{A}, \text{Referenced to } 25^\circ\text{C}$	-	0.8	-	$\text{V}/^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 600\text{V}, V_{GS} = 0\text{V}$	-	-	1	μA
		$V_{DS} = 480\text{V}, V_{GS} = 0\text{V}, T_C = 150^\circ\text{C}$	-	-	10	
I_{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 30\text{V}, V_{DS} = 0\text{V}$	-	-	± 100	nA

On Characteristics

$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250\mu\text{A}$	3.0	-	5.0	V
$R_{DS(\text{on})}$	Static Drain to Source On Resistance	$V_{GS} = 10\text{V}, I_D = 8.5\text{A}$	-	0.29	0.34	Ω
g_{FS}	Forward Transconductance	$V_{DS} = 20\text{V}, I_D = 8.5\text{A}$ (Note 4)	-	21	-	S

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{DS} = 25\text{V}, V_{GS} = 0\text{V}$	-	2285	3040	pF
C_{oss}	Output Capacitance	$f = 1\text{MHz}$	-	310	410	pF
C_{rss}	Reverse Transfer Capacitance		-	23	35	pF
$Q_g(\text{tot})$	Total Gate Charge at 10V		-	48	65	nC
Q_{gs}	Gate to Source Gate Charge	$V_{DS} = 480\text{V}, I_D = 17\text{A}$	-	13	-	nC
Q_{gd}	Gate to Drain "Miller" Charge	$V_{GS} = 10\text{V}$ (Note 4, 5)	-	20	-	nC

Switching Characteristics

$t_{d(\text{on})}$	Turn-On Delay Time	$V_{DD} = 300\text{V}, I_D = 17\text{A}$	-	48	106	ns
t_r	Turn-On Rise Time	$V_{GS} = 10\text{V}, R_{\text{GEN}} = 25\Omega$	-	79	168	ns
$t_{d(\text{off})}$	Turn-Off Delay Time		-	128	266	ns
t_f	Turn-Off Fall Time	(Note 4, 5)	-	62	134	ns

Drain-Source Diode Characteristics

I_S	Maximum Continuous Drain to Source Diode Forward Current	-	-	74	A	
I_{SM}	Maximum Pulsed Drain to Source Diode Forward Current	-	-	68	A	
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0\text{V}, I_{SD} = 17\text{A}$	-	-	1.4	V
t_{rr}	Reverse Recovery Time	$V_{GS} = 0\text{V}, I_{SD} = 17\text{A}$	-	575	-	ns
Q_{rr}	Reverse Recovery Charge	$dI_F/dt = 100\text{A}/\mu\text{s}$ (Note 4)	-	7.2	-	μC

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. $L = 5.8\text{mH}, I_{AS} = 17\text{A}, V_{DD} = 50\text{V}, R_G = 25\Omega, \text{Starting } T_J = 25^\circ\text{C}$
3. $I_{SD} \leq 17\text{A}, di/dt \leq 200\text{A}/\mu\text{s}, V_{DD} \leq \text{BV}_{\text{DSS}}, \text{Starting } T_J = 25^\circ\text{C}$
4. Pulse Test: Pulse width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$
5. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

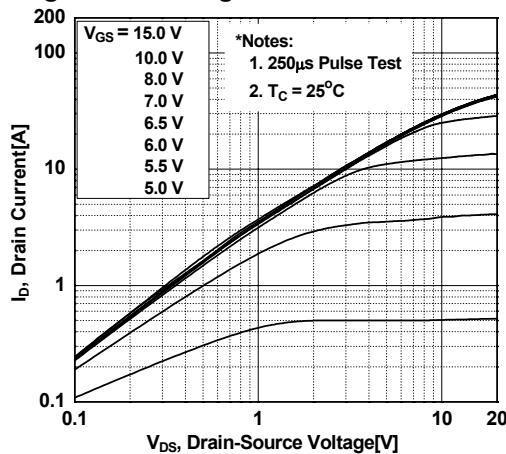


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

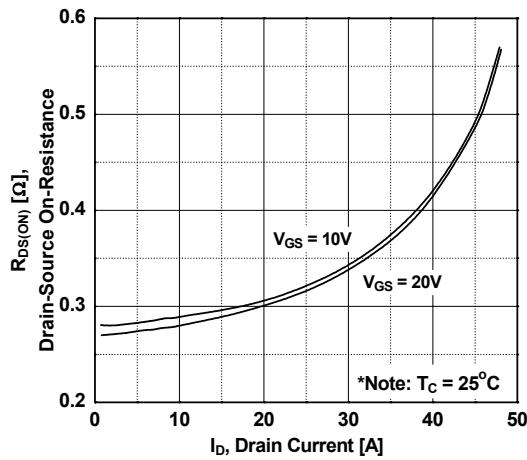


Figure 5. Capacitance Characteristics

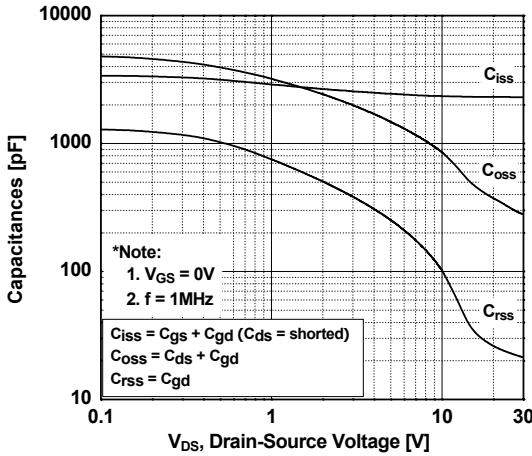


Figure 2. Transfer Characteristics

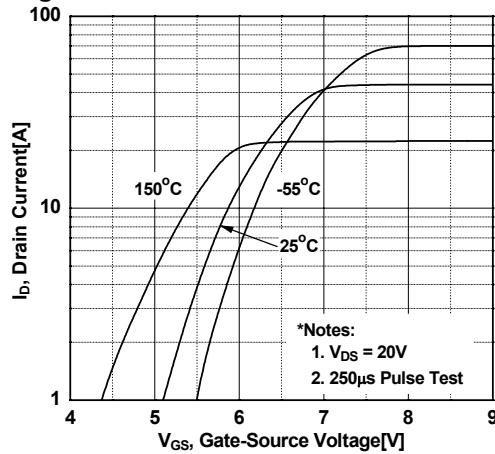


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

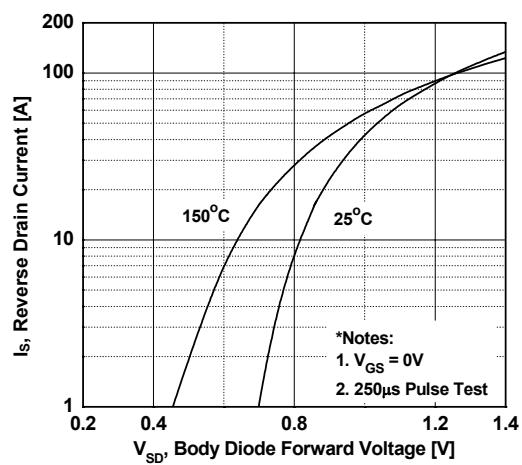


Figure 6. Gate Charge Characteristics

